

Notice of References Cited	Application/Control No. 10/501,381	Applicant(s)/Patent Under Reexamination PAHK ET AL.	
	Examiner Sang Nguyen	Art Unit 2877	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,989,895	01-2006	Buzzetti, Mike	356/237.1
*	B	US-6,831,738	12-2004	Rogers et al.	356/244
*	C	US-6,466,310	10-2002	Nguyen et al.	356/73.1
*	D	US-6,340,247	01-2002	Sakurai et al.	385/78
*	E	US-5,459,564	10-1995	Chivers, James T.	356/73.1
*	F	US-5,220,407	06-1993	Yamane et al.	356/625
*	G	US-5,177,557	01-1993	Yamane, Motohiro	356/73.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05118830 A	05-1993	Japan	SHIBANO, HIROSHI	
	O	JP 2002267403 A	09-2002	Japan	URUTA, HISAYA	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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